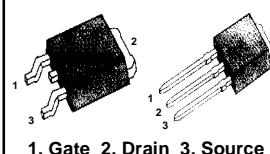


## FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- 175°C Operating Temperature
- Lower Leakage Current : 10 µA (Max.) @  $V_{DS} = 100V$
- Lower  $R_{DS(ON)}$  : 0.041 Ω (Typ.)

$BV_{DSS} = 100 V$   
 $R_{DS(on)} = 0.052 \Omega$   
 $I_D = 28 A$

D<sup>2</sup>-PAK I<sup>2</sup>-PAK

1. Gate 2. Drain 3. Source

## Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
$V_{DSS}$	Drain-to-Source Voltage	100	V
$I_D$	Continuous Drain Current ( $T_C=25^\circ C$ )	28	A
	Continuous Drain Current ( $T_C=100^\circ C$ )	19.8	
$I_{DM}$	Drain Current-Pulsed	110	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulsed Avalanche Energy	523	mJ
$I_{AR}$	Avalanche Current	28	A
$E_{AR}$	Repetitive Avalanche Energy	10.7	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	6.5	V/ns
$P_D$	Total Power Dissipation ( $T_A=25^\circ C$ ) *	3.8	W
	Total Power Dissipation ( $T_C=25^\circ C$ )	107	W
	Linear Derating Factor	0.71	W/°C
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	- 55 to +175	°C
$T_L$	Maximum Lead Temp. for Soldering Purposes, 1/8? from case for 5-seconds	300	

## Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{eJC}$	Junction-to-Case	--	1.4	°C/W
$R_{eJA}$	Junction-to-Ambient *	--	40	
$R_{eJA}$	Junction-to-Ambient	--	62.5	

\* When mounted on the minimum pad size recommended (PCB Mount).

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Rev. B1

Electrical Characteristics ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	100	--	--	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.11	--	V/ $^\circ\text{C}$	$\text{I}_D=250\mu\text{A}$ See Fig 7
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	--	4.0	V	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=250\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Source Leakage , Forward	--	--	100	nA	$\text{V}_{\text{GS}}=20\text{V}$
	Gate-Source Leakage , Reverse	--	--	-100		$\text{V}_{\text{GS}}=-20\text{V}$
$\text{I}_{\text{DSS}}$	Drain-to-Source Leakage Current	--	--	10	$\mu\text{A}$	$\text{V}_{\text{DS}}=100\text{V}$
		--	--	100		$\text{V}_{\text{DS}}=80\text{V}, \text{T}_C=150^\circ\text{C}$
$\text{R}_{\text{DS}(\text{on})}$	Static Drain-Source On-State Resistance	--	--	0.052	$\Omega$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=14\text{A}$ (4)
$\text{g}_{\text{FS}}$	Forward Transconductance	--	22.56	--	S	$\text{V}_{\text{DS}}=40\text{V}, \text{I}_D=14\text{A}$ (4)
$\text{C}_{\text{iss}}$	Input Capacitance	--	1320	1710	pF	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
$\text{C}_{\text{oss}}$	Output Capacitance	--	325	380		
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance	--	148	170		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	--	18	50	ns	$\text{V}_{\text{DD}}=50\text{V}, \text{I}_D=28\text{A}, \text{R}_G=9.1\Omega$ See Fig 13 (4) (5)
$t_r$	Rise Time	--	18	50		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	--	90	180		
$t_f$	Fall Time	--	56	120		
$\text{Q}_g$	Total Gate Charge	--	60	78	nC	$\text{V}_{\text{DS}}=80\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{I}_D=28\text{A}$ See Fig 6 & Fig 12 (4) (5)
$\text{Q}_{\text{gs}}$	Gate-Source Charge	--	10.8	--		
$\text{Q}_{\text{gd}}$	Gate-Drain( Miller? ) Charge	--	27.9	--		

## Source-Drain Diode Ratings and Characteristics

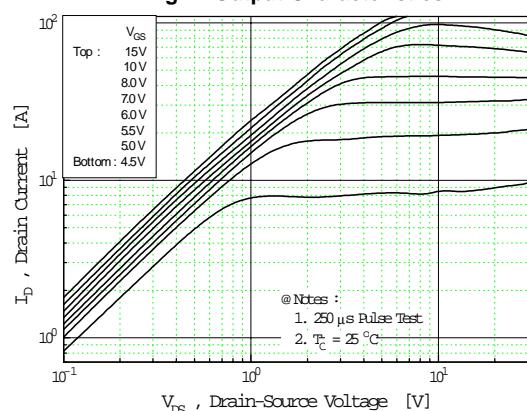
Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$\text{I}_S$	Continuous Source Current	--	--	28	A	Integral reverse pn-diode in the MOSFET
$\text{I}_{\text{SM}}$	Pulsed-Source Current (1)	--	--	110		
$\text{V}_{\text{SD}}$	Diode Forward Voltage (4)	--	--	1.5	V	$\text{T}_J=25^\circ\text{C}, \text{I}_S=28\text{A}, \text{V}_{\text{GS}}=0\text{V}$
$t_{\text{rr}}$	Reverse Recovery Time	--	132	--	ns	$\text{T}_J=25^\circ\text{C}, \text{I}_F=28\text{A}$ $d\text{I}_F/dt=100\text{A}/\mu\text{s}$ (4)
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge	--	0.63	--	$\mu\text{C}$	

## Notes :

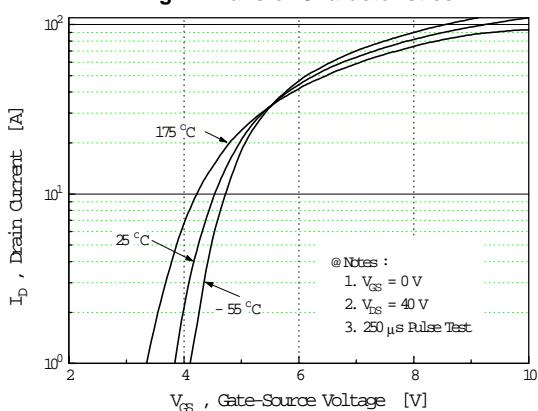
- (1) Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- (2)  $L=1\text{mH}, \text{I}_{\text{AS}}=28\text{A}, \text{V}_{\text{DD}}=25\text{V}, \text{R}_G=27\Omega$ , Starting  $\text{T}_J=25^\circ\text{C}$
- (3)  $\text{I}_{\text{SD}} \leq 28\text{A}, d\text{I}/dt \leq 400\text{A}/\mu\text{s}, \text{V}_{\text{DD}} \leq \text{BV}_{\text{DSS}}$ , Starting  $\text{T}_J=25^\circ\text{C}$
- (4) Pulse Test : Pulse Width = 250 $\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- (5) Essentially Independent of Operating Temperature

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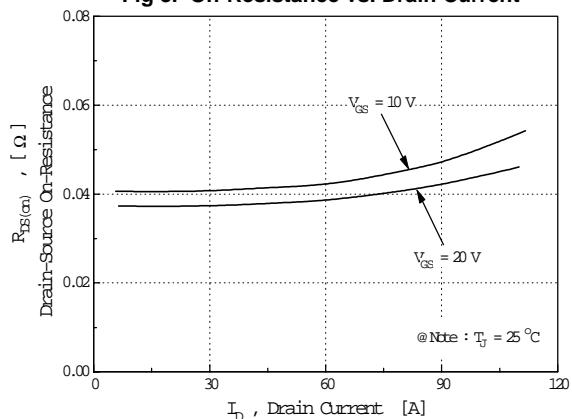
**Fig 1. Output Characteristics**



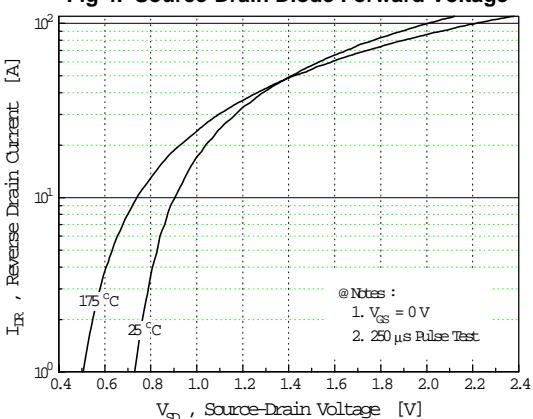
**Fig 2. Transfer Characteristics**



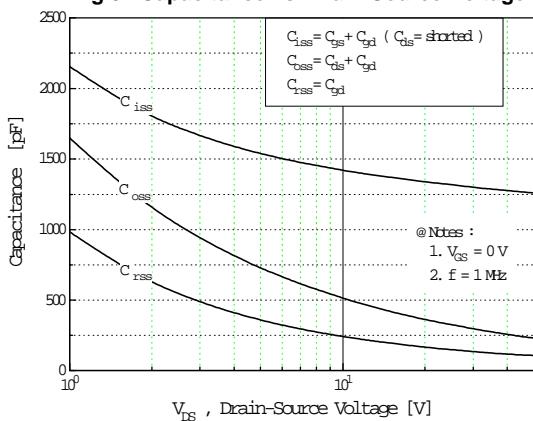
**Fig 3. On-Resistance vs. Drain Current**



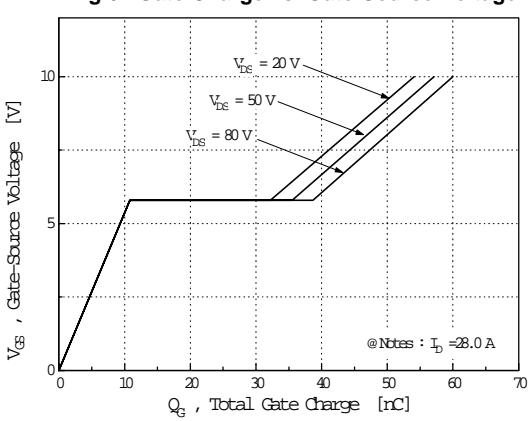
**Fig 4. Source-Drain Diode Forward Voltage**

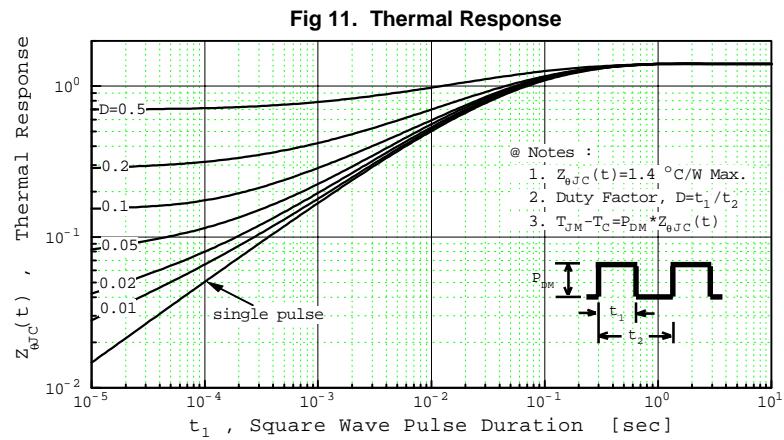
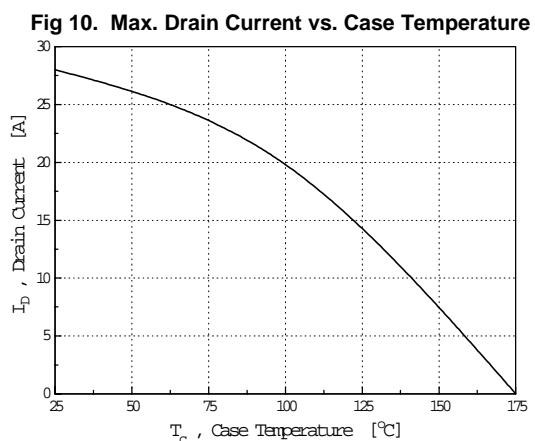
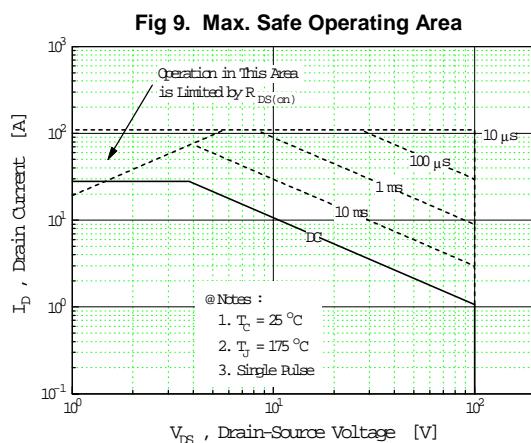
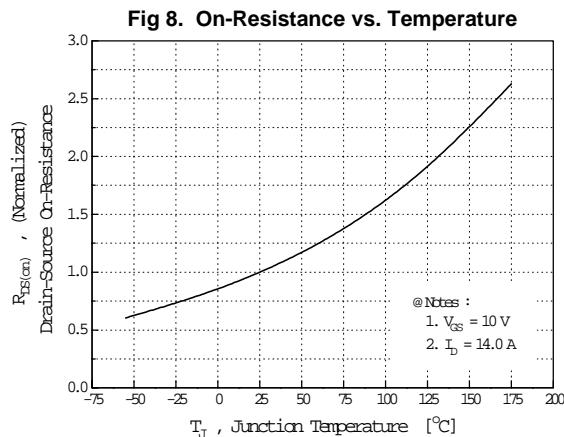
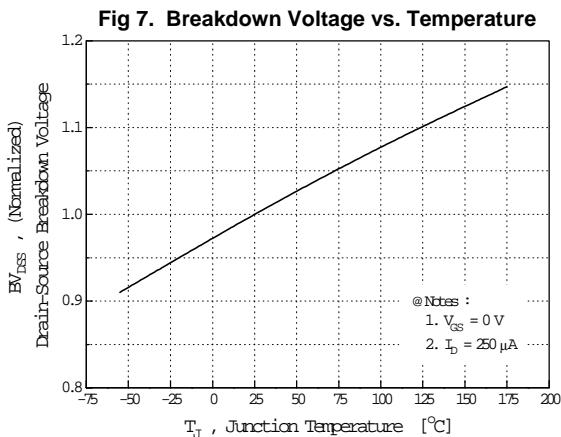


**Fig 5. Capacitance vs. Drain-Source Voltage**

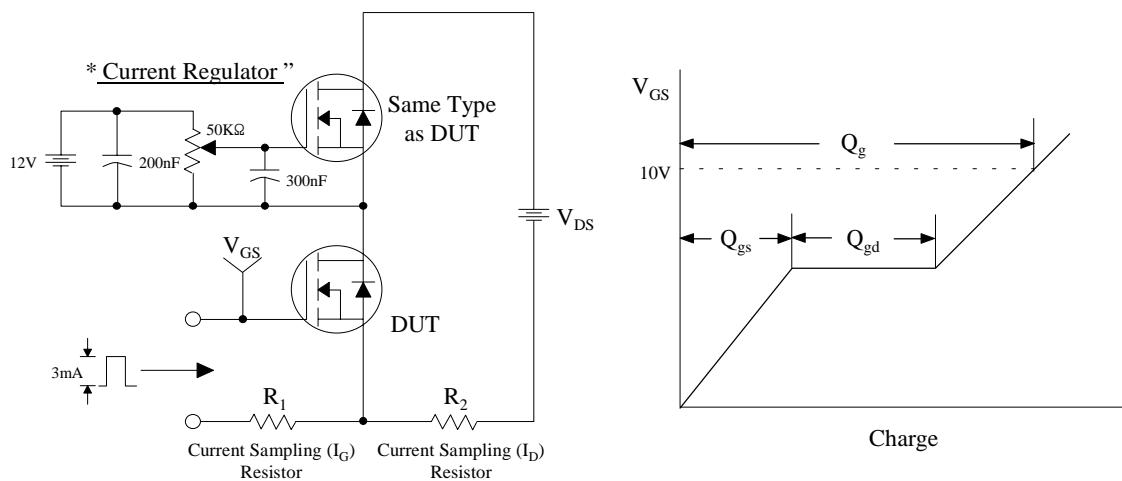


**Fig 6. Gate Charge vs. Gate-Source Voltage**

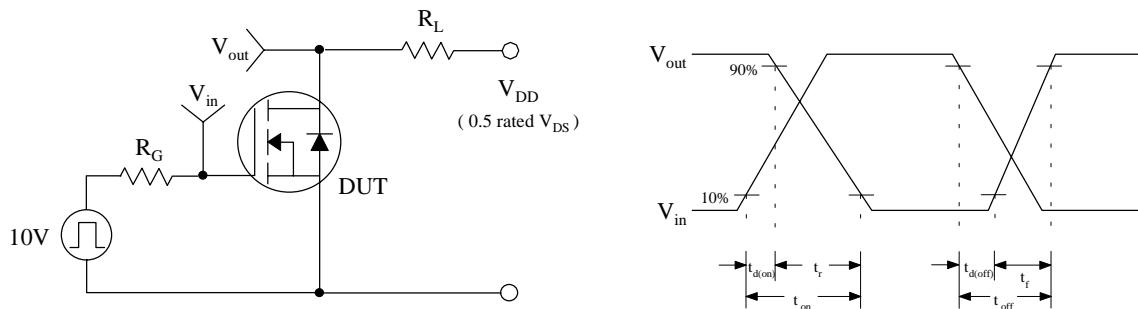




**Fig 12. Gate Charge Test Circuit & Waveform**



**Fig 13. Resistive Switching Test Circuit & Waveforms**



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

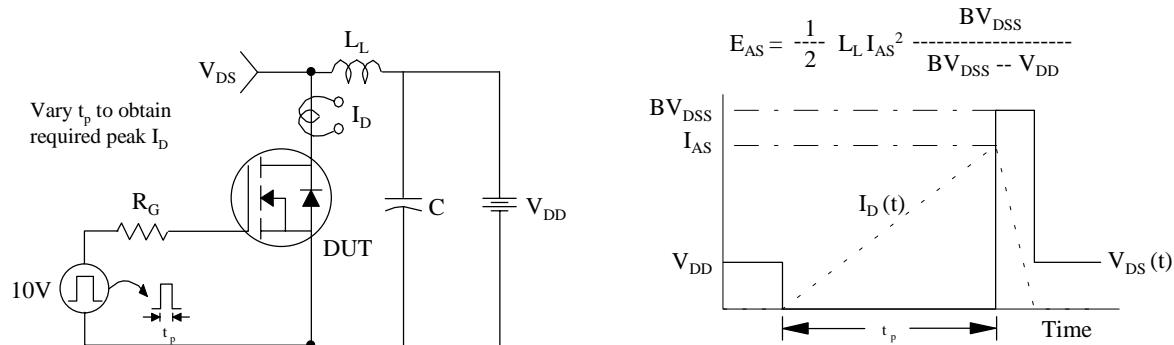
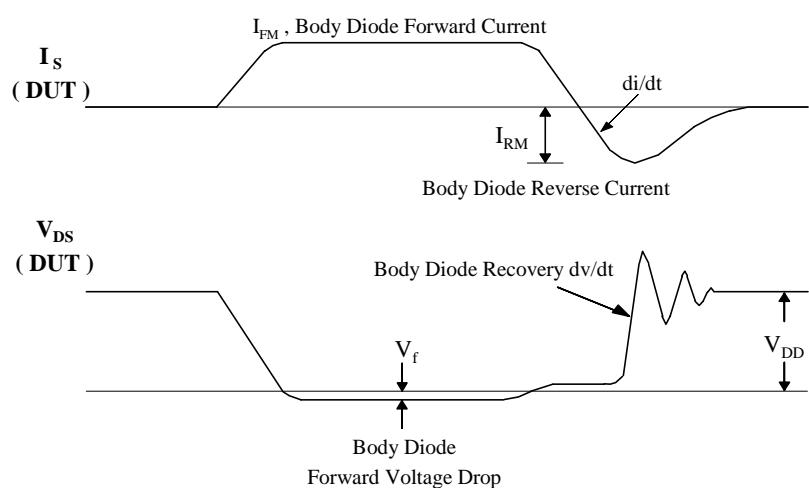
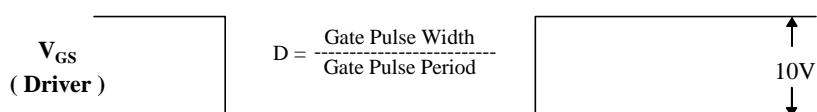
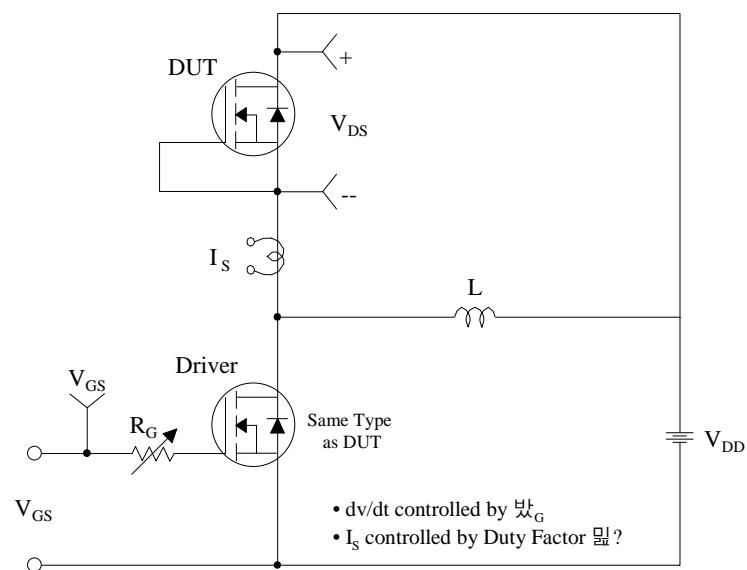


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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IRFW540A

100V N-Channel A-FET

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- Rugged Gate Oxide Technology
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- Lower R<sub>DS(ON)</sub> : 0.041Ω (Typ.)

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